

REMARKS:

The specification and claims of the referenced application have been amended in accordance with common U.S. Patent Practice and to remove the multiple dependencies of claims. Claims 1-4 canceled. New Claims 5-8 were added. No new matter has been introduced through the foregoing amendments. Entry is in order.

To the extent necessary, a petition for an extension of time under 37 C.F.R. 1.136 is hereby made. Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 07-1337 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Comparison circuit for analog/digital converter

BACKGROUND OF THE INVENTION

5 The invention pertains to a comparison circuit for an analog/digital converter. The comparison circuit comprises a network of comparators each comparing an analog voltage to be converted with a reference voltage. The analog voltage to be converted generally
 10 arises from a sample-and-hold module allowing the whole assembly of comparators of the network to receive the same analog voltage at the moment at which they perform the comparison with the reference voltage.

15 The reference voltages received by the comparators are distributed over a range in which the analog voltage can vary. The distribution is generally uniform over the range and it is for example obtained by means of a network of resistors, all of like value and linked in
 20 series between the terminals of a source of supply voltage of the comparator. There are substantially as many resistors as comparators. The reference voltages are then tapped off at the various inter-resistor junction points.

25 Each comparator comprises two outputs, one direct and the other inverse. The voltages present on its outputs are dependent on the potential difference between the analog voltage and the reference voltage received by
 30 the comparator concerned. Figure 1 represents three curves showing the variation in the voltage present on the direct output $On-1$, On and $On+1$ as a function of the analog voltage V , for three comparators C of rank $n-1$, n and $n+1$ in the network of comparators. These
 35 three comparators receive respectively reference voltages $V_{ref\ n-1}$, $V_{ref\ n}$ and $V_{ref\ n+1}$. The comparators receive reference voltages similar in their distribution over the range.

For a given comparator, for example the comparator of rank n, if its response were perfect, the voltage O_n present on its direct output ought to be zero when the analog voltage V is equal to the reference voltage V_n .
5 However, the response of the comparators is not perfect and a voltage mismatch, termed the offset voltage, is noted between the reference voltage $V_{ref\ n}$ and the analog voltage V causing a zero voltage O_n on the direct output of the comparator of rank n. In practice
10 it is noted that each comparator C has its own offset voltage independent of that of the other comparators. In Figure 1, the comparator C of rank $n-1$ has an offset voltage $Offset\ n-1$, the comparator C of rank n has an offset voltage $Offset\ n$ and the comparator C of rank
15 $n+1$ has an offset voltage $Offset\ n+1$. The offset voltages may be negative or positive. Their values are randomly distributed for the various comparators of an analog/digital converter. These offset voltages impair the accuracy of the converter and it is noted that they
20 tend to increase when the size of the electronic component on which the converter is made is reduced.

Additionally, the resolution LSB of an analog digital converter may be expressed by the mismatch in the
25 analog voltage modifying the value of a low-order bit at the output of the converter. The LSB resolution is expressed as follows:

$$LSB = \frac{V_{peak/peak}}{2^n}$$

30 where $V_{peak/peak}$ represents the maximum amplitude of the analog voltage that the converter can convert, and where n is the number of comparators in the network. If the resolution LSB is less than three times the offset
35 voltage, there is a loss of linearity of the converter and the low-order bit is no longer meaningful.

SUMMARY OF THE INVENTION

The aim of the invention is to reduce the effects of these offset voltages by averaging them over
5 neighboring converters. This reduction makes it possible to improve the resolution of the converter.

Accordingly, the subject of the invention is a comparison circuit for an analog/digital converter
10 comprising a network of comparators each comparing an analog voltage to be converted with a reference voltage, the reference voltages being distributed over a range in which the analog voltage can vary, each comparator comprising a direct output and an inverse
15 output, characterized in that each output, direct or inverse, is linked to the input of a voltage follower, the outputs of each voltage follower being connected either to inputs of a first network of resistors delivering at its outputs, mean voltages that are the
20 average of those present on direct outputs of the comparators receiving reference voltages similar in their distribution over the range, or to inputs of a second network of resistors delivering at its outputs, mean voltages that are the averages of those present on
25 inverse outputs of comparators receiving reference voltages similar in their distribution over the range.

BRIEF DESCRIPTION OF THE DRAWING

30 The invention will be better understood and other advantages will become apparent on reading the detailed description of an embodiment given by way of example and illustrated by the appended drawing in which
35 Figure 1 represents several curves showing the variation of the voltage present on the direct outputs of comparators as a function of the analog voltage V which is applied to it; this figure has already been commented on above;

Figure 2 represents a comparison circuit comprising several networks of resistors making it possible to carry out the averaging of voltages of direct outputs of several neighboring comparators.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

Figure 2 represents a comparison circuit 1 comprising a network of comparators each comparing an analog voltage V to be converted with a reference voltage. In Figure 2, three comparators C_{n-1} , C_n and C_{n+1} have been represented, n representing their rank in the network of comparators. Each comparator comprises two inputs and the analog voltage V is present on one of these inputs. The other input receives a reference voltage specific to each comparator C . The three comparators C_{n-1} , C_n and C_{n+1} respectively receive reference voltages $V_{ref\ n-1}$, $V_{ref\ n}$ and $V_{ref\ n+1}$ obtained by means of a network of resistors R , all linked in series between the terminals of a source of supply voltage V_{cc} of the comparator. Each comparator C_{n-1} , C_n or C_{n+1} comprises two outputs, one direct, respectively O_{n-1} , O_n or O_{n+1} , the other inverse respectively $\overline{O_{n-1}}$, $\overline{O_n}$ or $\overline{O_{n+1}}$. The voltages present on its outputs are dependent on the potential difference between the analog voltage V and the reference voltage $V_{ref\ n-1}$, $V_{ref\ n}$ or $V_{ref\ n+1}$ received by the comparator C concerned. The voltages present on the outputs of the various comparators C vary, for example, as represented in Figure 1. For a given comparator C , the voltage present on the inverse output \overline{O} is equal to the voltage symmetric to the voltage present on its direct output O with respect to a mean voltage which it delivers.

Each output, direct O_{n-1} , O_n or O_{n+1} or inverse $\overline{O_{n-1}}$, $\overline{O_n}$ or $\overline{O_{n+1}}$, is linked to the input of a voltage follower A . Each voltage follower A delivers a voltage equal to the voltage present on that output of the

comparator to which it is linked and has a very low output impedance.

The outputs of each voltage follower A are connected
5 either to an input of a first network 2 of resistors
delivering at its outputs $O'n-1$, $O'n$ and $O'n+1$, mean
voltages that are the average of those present on the
direct outputs of the comparators $Cn-1$, Cn and $Cn+1$, or
to an input of a second network of resistors delivering
10 at its outputs $\overline{O'n-1}$, $\overline{O'n}$ and $\overline{O'n+1}$, mean voltages
that are the average of those present on the inverse
outputs of the comparators $Cn-1$, Cn and $Cn+1$. So as not
to overburden Figure 2 only the first network 2 of
resistors has been represented. Advantageously the two
15 networks of resistors have the same structure.

Advantageously, each network of resistors comprises a
first series assembly of two identical pairs of two
identical resistors in series, $R1$, $R2$, on the one hand,
20 $R3$, $R4$ on the other hand, and a second series assembly
of two identical pairs of two identical resistors in
series $R5$, $R6$ on the one hand, $R7$, $R8$ on the other
hand. The inputs of the network of resistors are
constituted by the ends and the midpoint of the first
25 series assembly, and the outputs of the network of
resistors are constituted by the ends and the midpoint
of the second series assembly, the midpoint of the
first pair and of the second pair of resistors of the
first assembly are connected respectively to the
30 midpoint of the first pair and of the second pair of
the second assembly. This structure of network of
resistors is repeated so as to be able to link up to
the outputs of all the comparators C and thus provide
as many outputs O' of the network of resistors as
35 outputs O of the comparators C.

The transfer function of the output $O'n$ of the first
network 2 can then be expressed in the following
manner:

$$O'n = \frac{\frac{O_n + O_{n+1}}{2} + \frac{O_n + O_{n-1}}{2}}{2}$$

The first two networks of resistors make it possible to
5 reduce the statistical error due to the various offset
voltages of the comparators. More precisely, it is
possible to determine the standard deviation σ of the
offset voltages of the assembly of comparators C of the
network. It is possible, with the aid of the transfer
10 function of the first resistor network to determine an
equivalent standard deviation σ' of the comparators as
seen from the outputs of the first network 2 of
resistors. The equivalent standard deviation σ' may be
expressed in the following manner:

15

$$\sigma' = \sigma \sqrt{\frac{3}{8}} \approx 0.6\sigma$$

This reduction in the effect of the offset voltage of
the comparators makes it possible practically to
20 improve the resolution by a low-order bit.

The combination of the voltage followers A with the
network of resistors makes it possible not to lose gain
at the output of the network of resistors with respect
25 to the output of the network of comparators. In the
absence of a voltage follower A, the reduction in the
effect of the offset voltage of the comparators would
be lower.

30 Advantageously the outputs $O'n-1$, $O'n$ and $O'n+1$ of the
first network 2 of resistors are connected, by way of
voltage followers A, to inputs of a third network 3 of
resistors delivering to its outputs $O''n-1$, $O''n$ and
 $O''n+1$ mean voltages that are the average of those
35 present on neighboring inputs of the third network of
resistors. Likewise, the outputs $\overline{O'n-1}$, $\overline{O'n}$ and $\overline{O'n+1}$

of the second network of resistors are connected, by way of voltage followers A, to inputs of a fourth network of resistors delivering at its outputs O''_{n-1} , O''_n or O''_{n+1} , mean voltages that are the average of those present on neighboring inputs of the fourth network of resistors. As before, so as not to overburden Figure 2, the fourth network of resistors is not represented. Advantageously, the four networks of resistors have the same structure. The transfer function of the output O''_n of the second network 3 of resistors can be expressed in the following manner:

$$O''_n = \frac{\frac{O'_n + O'_{n+1}}{2} + \frac{O'_n + O'_{n-1}}{2}}{2}$$

As before, an equivalent standard deviation σ'' can be expressed in the following manner:

$$\sigma'' = \sigma' \sqrt{\frac{3}{8}} = \sigma \sqrt{\frac{3}{8}} \times \sqrt{\frac{3}{8}} \approx 0.36\sigma$$

An appreciable decrease in the effect of the offset voltage of the comparators C can be seen here, this decrease being obtained with the aid of the second stage of network of resistors. The voltage followers A connected between the two networks of resistors avoid any loss of gain. The invention could be generalized by chaining together other networks of resistors, decorrelated from the previous networks by means of voltage followers, downstream of the two described here. Nevertheless, this chaining appreciably increases the number of components present on a substrate on which the analog digital converter is made.

The invention can be implemented in respect of a comparison circuit architecture comprising comparators all working in parallel. This architecture is well known in the literature by the name "flash". The

invention may also be implemented in respect of a so-called "folding" comparison circuit architecture comprising a smaller number of comparators working in parallel. These comparators are then used several times
5 over the range. This architecture is well known in the literature.

It will be readily seen by one of ordinary skill in the art that embodiments according to the present invention fulfill many of the advantages set forth above. After reading the foregoing specification, one of ordinary skill will be able to affect various changes, substitutions of equivalents and various other aspects of the invention as broadly disclosed herein.
10 It is therefore intended that the protection granted hereon be limited only by the definition contained in the appended claims and equivalents thereof.
15

ABSTRACT

~~Comparison circuit for analog/digital converter~~

The invention pertains to a comparison circuit for an analog/digital converter. In order to reduce the effect of the offset voltages of the various comparators of the comparison circuit, voltage followers $[(A)]$ and a resistor network $[(2)]$ delivering at its outputs $[(O', \bar{O}')]$, mean voltages that are the average of those present on outputs $[(O, \bar{O})]$ of the comparators $[(C)]$ are linked downstream of the outputs $[(O)]$ of the comparators $[(C)]$.

~~Figure 2.~~